


<b>Search Notes</b>  	<b>Application/Control No.</b>  10615860	<b>Applicant(s)/Patent Under Reexamination</b>  ZENG ET AL.
	<b>Examiner</b>  Seth, Manav	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	162-167	5/15/2007	ms
345	589-593,600-601,605,643,549,22,72,83,153,155	5/15/2007	ms
358	515,518	5/15/2007	ms
Above	Updated	11/3/2007	ms

SEARCH NOTES		
Search Notes	Date	Examiner
East (Text and Class) search	5/15/2007	ms
STIC Plus Search	5/15/2007	ms
IEEE Search	5/15/2007	ms
Inventor Search	5/15/2007	ms
Consulted Samir Ahmed (Primary Examiner)	5/14/2007	ms
QEM Meeting	5/15/2007	ms
East (Text and Class) search updated	8/31/2007	ms
Interference Search - See attached search report	8/31/2007	ms
East (Text and Class) Search updated	11/3/2007	ms
Interference search updated - see attached search report	11/3/2007	ms
IDS search	11/3/2007	ms

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	PGPUB text search - see attached searh report	8/31/2007	ms
	PGPUB text search updated	11/3/2007	ms